#### DATA SHEET

# **General Description**

The 843251I-15 is an Ethernet Clock Generator. The 843251I-15 uses an 18pF parallel resonant crystal over the range of 23.2MHz - 30MHz. For Ethernet applications, a 25MHz crystal is used. The 843251I-15 uses IDT's  $3^{\rm rd}$  generation low phase noise VCO technology, and can achieve <1ps rms phase jitter performance over the 1.875MHz - 20MHz integration range. The 843251I-15 is packaged in a small 8-pin TSSOP, making it ideal for use in systems with limited board space.

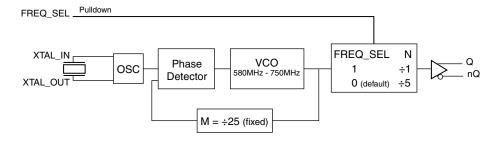
#### **Features**

- One differential 3.3V LVPECL output pair
- Crystal oscillator interface, 18pF parallel resonant crystal (23.2MHz – 30MHz)
- Output frequency range: 116MHz 150MHz and 580MHz – 750MHz
- VCO range: 580MHz 750MHz
- RMS phase jitter @ 125MHz, using a 25MHz crystal (1.875MHz – 20MHz): 0.45ps (typical), 3.3V
- Full 3.3V or 2.5V supply modes
- -40°C to 85°C ambient operating temperature
- Available in lead-free (RoHS 6) package

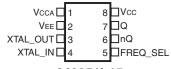
#### **Common Configuration Table**

	Inputs						
Crystal Frequency (MHz)	FREQ_SEL	М	N	Multiplication Value M/N	Output Frequency (MHz)		
25	1	25	1	25	625		
26.667	1	25	1	25	666.67		
25	0	25	5	5	125		
26.667	0	25	5	5	133.33		

# **Block Diagram**



# **Pin Assignment**



843251I-15 8 Lead TSSOP 4.40mm x 3.0mm x 0.925mm package body G Package Top View



# **Pin Description and Pin Characteristic Tables**

**Table 1. Pin Descriptions** 

Number	Name	Туре		Description
1	V <sub>CCA</sub>	Power		Analog supply pin.
2	V <sub>EE</sub>	Power		Negative supply pin.
3, 4	XTAL_OUT XTAL_IN	Input		Crystal oscillator interface. XTAL_IN is the input, XTAL_OUT is the output.
5	FREQ_SEL	Input	Pulldown	Frequency select pin. LVCMOS/LVTTL interface levels.
6, 7	nQ, Q	Output		Differential output pair. LVPECL interface levels.
8	V <sub>CC</sub>	Power		Core supply pin.

NOTE: Pulldown refers to internal input resistors. See Table 2, Pin Characteristics, for typical values.

### **Table 2. Pin Characteristics**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C <sub>IN</sub>	Input Capacitance			4		pF
R <sub>PULLDOWN</sub>	Input Pulldown Resistor			51		kΩ



# **Absolute Maximum Ratings**

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed

in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V <sub>CC</sub>	4.6V
Inputs, V <sub>I</sub>	-0.5V to V <sub>CC</sub> + 0.5V
Outputs, I <sub>O</sub>	
Continuous Current	50mA
Surge Current	100mA
Package Thermal Impedance, $\theta_{JA}$	129.5°C/W (0 mps)
Storage Temperature, T <sub>STG</sub>	-65°C to 150°C

## **DC Electrical Characteristics**

Table 3A. Power Supply DC Characteristics,  $V_{CC} = 3.3V \pm 5\%$ ,  $V_{EE} = 0V$ ,  $T_A = -40^{\circ}C$  to  $85^{\circ}C$ 

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V <sub>CC</sub>	Core Supply Voltage		3.135	3.3	3.465	V
V <sub>CCA</sub>	Analog Supply Voltage		V <sub>CC</sub> - 0.10	3.3	V <sub>CC</sub>	V
I <sub>EE</sub>	Power Supply Current				83	mA
I <sub>CCA</sub>	Analog Supply Current				10	mA

## Table 3B. Power Supply DC Characteristics, $V_{CC} = 2.5V \pm 5\%$ , $V_{EE} = 0V$ , $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V <sub>CC</sub>	Core Supply Voltage		2.375	2.5	2.625	V
V <sub>CCA</sub>	Analog Supply Voltage		V <sub>CC</sub> - 0.08	2.5	V <sub>CC</sub>	V
I <sub>EE</sub>	Power Supply Current				78	mA
I <sub>CCA</sub>	Analog Supply Current				8	mA

## Table 3C. LVCMOS/LVTTL DC Characteristics, $V_{CC} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$ , $V_{EE} = 0V$ , $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V	Input High Voltage	V <sub>CC</sub> = 3.3V	2		V <sub>CC</sub> + 0.3	V
V <sub>IH</sub>	/ <sub>IH</sub> Input High Voltage	V <sub>CC</sub> = 2.5V	1.7		V <sub>CC</sub> + 0.3	V
V	Innut Law Valtage	V <sub>CC</sub> = 3.3V	-0.3		0.8	V
V <sub>IL</sub>	Input Low Voltage	V <sub>CC</sub> = 2.5V	-0.3		0.7	٧
I <sub>IH</sub>	Input High Current	V <sub>CC</sub> = V <sub>IN</sub> = 3.465V or 2.625V			150	μA
I <sub>IL</sub>	Input Low Current	V <sub>CC</sub> = 3.465V or 2.625V, V <sub>IN</sub> = 0V	-5			μΑ



Table 3D. LVPECL DC Characteristics,  $V_{CC}$  = 3.3V  $\pm$  5%,  $V_{EE}$  = 0V,  $T_A$  = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V <sub>OH</sub>	Output High Current; NOTE 1		V <sub>CC</sub> – 1.4		V <sub>CC</sub> - 0.9	V
V <sub>OL</sub>	Output Low Current; NOTE 1		V <sub>CC</sub> - 2.0		V <sub>CC</sub> – 1.7	V
V <sub>SWING</sub>	Peak-to-Peak Output Voltage Swing		0.6		1.0	V

NOTE 1: Outputs termination with  $50\Omega$  to  $V_{CC}$  –  $2V\!.$ 

Table 3E. LVPECL DC Characteristics,  $V_{CC} = 2.5V \pm 5\%$ ,  $V_{EE} = 0V$ ,  $T_A = -40$ °C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V <sub>OH</sub>	Output High Current; NOTE 1		V <sub>CC</sub> – 1.4		V <sub>CC</sub> - 0.9	٧
V <sub>OL</sub>	Output Low Current; NOTE 1		V <sub>CC</sub> - 2.0		V <sub>CC</sub> – 1.5	٧
V <sub>SWING</sub>	Peak-to-Peak Output Voltage Swing		0.4		1.0	٧

NOTE 1: Outputs termination with  $50\Omega$  to  $\mbox{V}_{\mbox{CC}}$  – 2V.

### **Table 4. Crystal Characteristics**

Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation			Fundamental		
Frequency		23.2		30	MHz
Equivalent Series Resistance (ESR)				40	Ω
Shunt Capacitance				7	pF

NOTE: It is not recommended to overdrive the crystal input with an external clock.



## **AC Electrical Characteristics**

Table 5A. AC Characteristics,  $V_{CC}$  = 3.3V ± 5%,  $V_{EE}$  = 0V,  $T_A$  = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
	Output Fraguency	FREQ_SEL = 0	116		150	MHz
f <sub>OUT</sub>	Output Frequency	FREQ_SEL = 1	580		750	MHz
fii+( <i>Q</i> )\	RMS Phase Jitter, Random;	125MHz, (Integration Range: 1.875MHz – 20MHz)		0.45		ps
<i>t</i> jit(Ø)	NOTE 1	625MHz, (Integration Range: 1.875MHz – 20MHz)		0.34		ps
$t_R / t_F$	Output Rise/Fall Time	20% to 80%	100		600	ps
odc	Output Duty Cycle		47		53	%

NOTE 1: Refer to Phase Noise Plots.

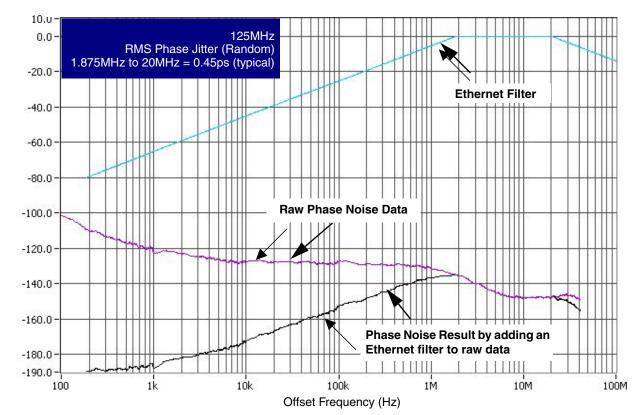
Table 5B. AC Characteristics,  $V_{CC}$  = 2.5V ± 5%,  $V_{EE}$  = 0V,  $T_A$  = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
4	Output Frequency	FREQ_SEL = 0	116		150	MHz
† <sub>OUT</sub>	Output Frequency	FREQ_SEL = 1	580		750	MHz
fiit(O)	RMS Phase Jitter, Random; NOTE 1	125MHz, (Integration Range: 1.875MHz – 20MHz)		0.44		ps
ijit(Ø)		625MHz, (Integration Range: 1.875MHz – 20MHz)		0.33		ps
t <sub>R</sub> / t <sub>F</sub>	Output Rise/Fall Time	20% to 80%	100		600	ps
odc	Output Duty Cycle		45		55	%

NOTE 1: Refer to Phase Noise Plots.

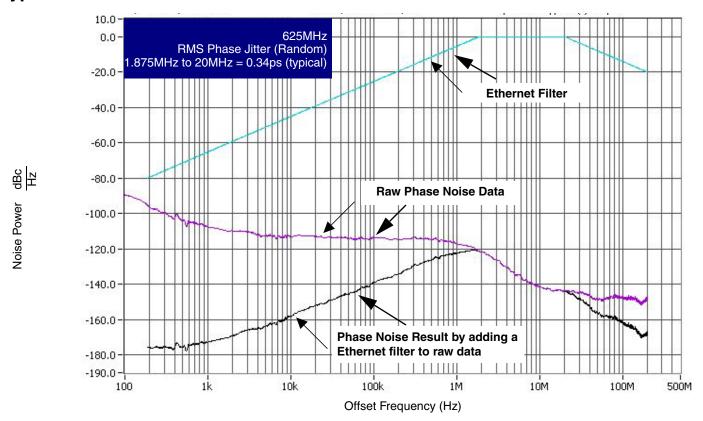


# Typical Phase Noise at 125MHz @ 3.3V



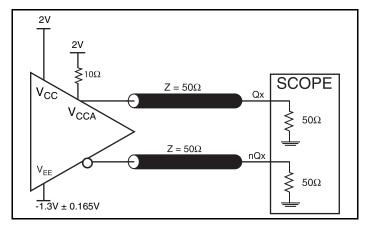


# Typical Phase Noise at 625MHz @ 3.3V

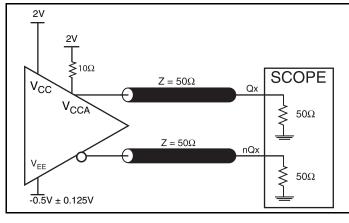




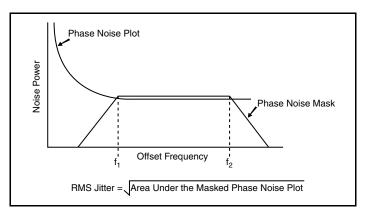
## **Parameter Measurement Information**



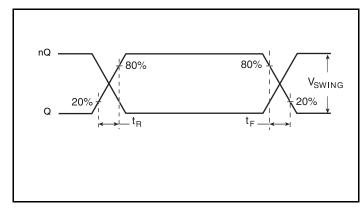
3.3V LVPECL Output Load AC Test Circuit



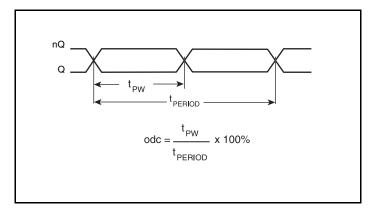
2.5V LVPECL Output Load AC Test Circuit



**RMS Phase Jitter** 



**Output Rise/Fall Time** 



**Output Duty Cycle/Pulse Width/Period** 



# **Application Information**

### **Power Supply Filtering Technique**

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. To achieve optimum jitter performance, power supply isolation is required. The 843251I-15 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL.  $V_{CC}$  and  $V_{CCA}$  should be individually connected to the power supply plane through vias, and  $0.01\mu F$  bypass capacitors should be used for each pin. Figure 1 illustrates this for a generic  $V_{CC}$  pin and also shows that  $V_{CCA}$  requires that an additional  $10\Omega$  resistor along with a  $10\mu F$  bypass capacitor be connected to the  $V_{CCA}$  pin.

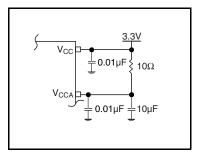


Figure 1. Power Supply Filtering

## **Crystal Input Interface**

The 843251I-15 has been characterized with 18pF parallel resonant crystals. The capacitor values, C1 and C2, shown in *Figure 2* below were determined using a 25MHz, 18pF parallel resonant crystal and were chosen to minimize the ppm error. The optimum C1 and C2 values can be slightly adjusted for different board layouts.

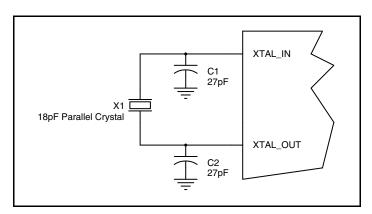


Figure 2. Crystal Input Interface



### **Overdriving the XTAL Interface**

The XTAL\_IN input can be overdriven by an LVCMOS driver or by one side of a differential driver through an AC coupling capacitor. The XTAL\_OUT pin can be left floating. The amplitude of the input signal should be between 500mV and 1.8V and the slew rate should not be less than 0.2V/ns. For 3.3V LVCMOS inputs, the amplitude must be reduced from full swing to at least half the swing in order to prevent signal interference with the power rail and to reduce internal noise. *Figure 3A* shows an example of the interface diagram for a high speed 3.3V LVCMOS driver. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the crystal input will attenuate the signal in half. This can be done in one of two

ways. First, R1 and R2 in parallel should equal the transmission line impedance. For most  $50\Omega$  applications, R1 and R2 can be  $100\Omega$ . This can also be accomplished by removing R1 and changing R2 to  $50\Omega$ . The values of the resistors can be increased to reduce the loading for a slower and weaker LVCMOS driver. Figure 3B shows an example of the interface diagram for an LVPECL driver. This is a standard LVPECL termination with one side of the driver feeding the XTAL\_IN input. It is recommended that all components in the schematics be placed in the layout. Though some components might not be used, they can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a quartz crystal as the input.

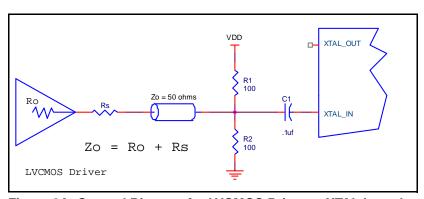


Figure 3A. General Diagram for LVCMOS Driver to XTAL Input Interface

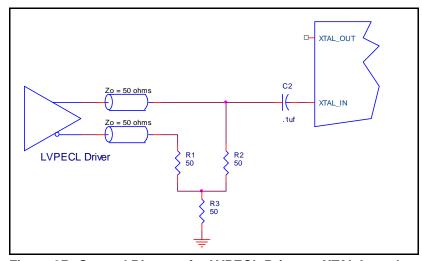


Figure 3B. General Diagram for LVPECL Driver to XTAL Input Interface



### **Termination for 3.3V LVPECL Outputs**

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive  $50\Omega$ 

transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figures 4A and 4B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

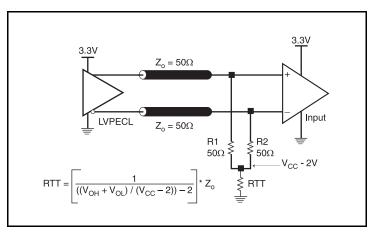


Figure 4A. 3.3V LVPECL Output Termination

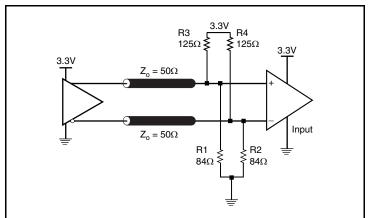


Figure 4B. 3.3V LVPECL Output Termination



## **Termination for 2.5V LVPECL Outputs**

Figure 5A and Figure 5B show examples of termination for 2.5V LVPECL driver. These terminations are equivalent to terminating  $50\Omega$  to  $V_{CC}-2V$ . For  $V_{CC}=2.5V$ , the  $V_{CC}-2V$  is very close to

ground level. The R3 in Figure 5B can be eliminated and the termination is shown in *Figure 5C*.

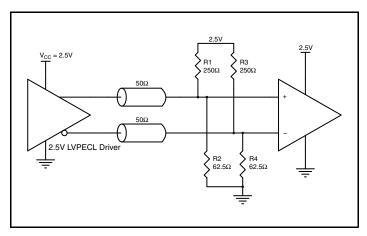


Figure 5A. 2.5V LVPECL Driver Termination Example

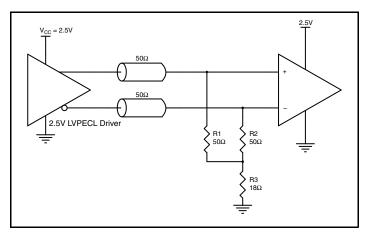


Figure 5B. 2.5V LVPECL Driver Termination Example

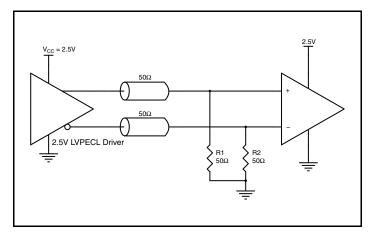


Figure 5C. 2.5V LVPECL Driver Termination Example



### **Schematic Example**

Figure 6 shows an example of 843251I-15 application schematic. In this example, the device is operated at  $V_{CC}=3.3V$ . The 18pF parallel resonant 25MHz crystal is used. The C1 = 27pF and C2 = 27pF are recommended for frequency accuracy. For different board layout, the C1 and C2 may be slightly adjusted for optimizing

frequency accuracy. Two examples of LVPECL termination are shown in this schematic. Additional termination approaches are shown in the *LVPECL Termination Application Note*.

Note: Thermal pad (E-pad) must be connected to ground (V<sub>EE</sub>).

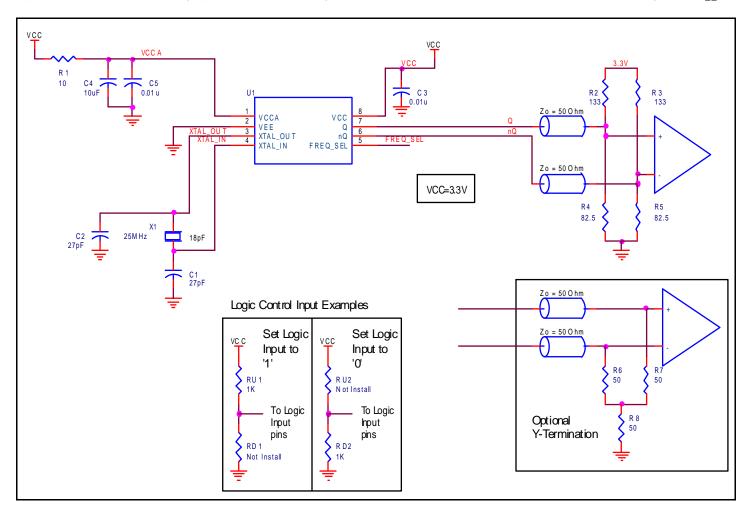


Figure 6. 843251I-15 Schematic Example



### **Power Considerations**

This section provides information on power dissipation and junction temperature for the 843251I-15. Equations and example calculations are also provided.

#### 1. Power Dissipation.

The total power dissipation for the 843251I-15 is the sum of the core power plus the power dissipated in the load(s). The following is the power dissipation for  $V_{CC} = 3.3V + 5\% = 3.465V$ , which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)<sub>MAX</sub> = V<sub>CC MAX</sub> \* I<sub>EE MAX</sub> = 3.465V \* 83mA = 287.60mW
- Power (outputs)<sub>MAX</sub> = 30mW/Loaded Output pair

Total Power\_MAX (3.3V, with all outputs switching) = 287.60mW + 30mW = 317.60mW

#### 2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature is 125°C.

The equation for Tj is as follows: Tj =  $\theta_{JA}$  \* Pd\_total + T<sub>A</sub>

Tj = Junction Temperature

 $\theta_{JA}$  = Junction-to-Ambient Thermal Resistance

Pd\_total = Total Device Power Dissipation (example calculation is in section 1 above)

T<sub>A</sub> = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance  $\theta_{JA}$  must be used. Assuming a moderate air flow of 1 meter per second and a multi-layer board, the appropriate value is 125.5°C/W per Table 6 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

 $85^{\circ}\text{C} + 0.318\text{W} * 125.5^{\circ}\text{C/W} = 124.9^{\circ}\text{C}$ . This is below the limit of  $125^{\circ}\text{C}$ .

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 6. Thermal Resistance  $\theta_{JA}$  for 8 Lead TSSOP, Forced Convection

$\theta_{\sf JA}$ vs. Air Flow			
Meters per Second	0	1	2.5
Multi-Layer PCB, JEDEC Standard Test Boards	129.5°C/W	125.5°C/W	123.5°C/W



#### 3. Calculations and Equations.

The purpose of this section is to derive the power dissipated into the load.

LVPECL output driver circuit and termination are shown in Figure 7.

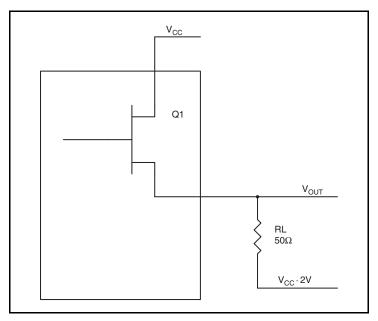


Figure 7. LVPECL Driver Circuit and Termination

To calculate worst case power dissipation into the load, use the following equations which assume a  $50\Omega$  load, and a termination voltage of  $V_{CC}$  – 2V.

- For logic high,  $V_{OUT} = V_{OH\_MAX} = V_{CC\_MAX} 0.9V$  $(V_{CC\_MAX} - V_{OH\_MAX}) = 0.9V$
- For logic low, V<sub>OUT</sub> = V<sub>OL\_MAX</sub> = V<sub>CC\_MAX</sub> 1.7V
  (V<sub>CC\_MAX</sub> V<sub>OL\_MAX</sub>) = 1.7V

Pd\_H is power dissipation when the output drives high.

Pd\_L is the power dissipation when the output drives low.

$$Pd\_H = [(V_{OH\_MAX} - (V_{CC\_MAX} - 2V))/R_L] * (V_{CC\_MAX} - V_{OH\_MAX}) = [(2V - (V_{CC\_MAX} - V_{OH\_MAX}))/R_L] * (V_{CC\_MAX} - V_{OH\_MAX}) = [(2V - 0.9V)/50\Omega] * 0.9V = \textbf{19.8mW}$$

$$Pd\_L = [(V_{OL\_MAX} - (V_{CC\_MAX} - 2V))/R_L] * (V_{CC\_MAX} - V_{OL\_MAX}) = [(2V - (V_{CC\_MAX} - V_{OL\_MAX}))/R_L] * (V_{CC\_MAX} - V_{OL\_MAX}) = [(2V - 1.7V)/50\Omega] * 1.7V = \textbf{10.2mW}$$

Total Power Dissipation per output pair = Pd\_H + Pd\_L = 30mW



# **Reliability Information**

# Table 7. $\theta_{\text{JA}}$ vs. Air Flow Table for a 8 Lead TSSOP

θ <sub>JA</sub> vs. Air Flow			
Meters per Second	0	1	2.5
Multi-Layer PCB, JEDEC Standard Test Boards	129.5°C/W	125.5°C/W	123.5°C/W

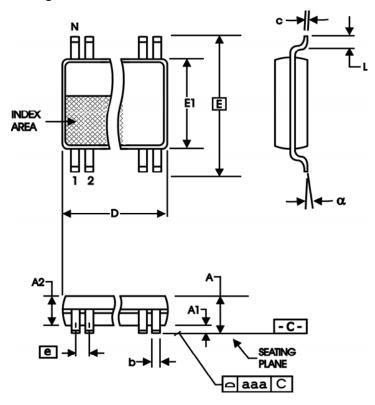
## **Transistor Count**

The transistor count for 843251I-15 is: 2395



# **Package Outline and Package Dimensions**

Package Outline - G Suffix for 8 Lead TSSOP



**Table 8. Package Dimensions** 

All Dimensions in Millimeters			
Symbol	Minimum	Maximum	
N	8		
Α		1.20	
A1	0.05	0.15	
A2	0.80	1.05	
b	0.19	0.30	
С	0.09	0.20	
D	2.90	3.10	
E	6.40 Basic		
E1	4.30	4.50	
е	0.65 Basic		
L	0.45	0.75	
α	0°	8°	
aaa		0.10	

Reference Document: JEDEC Publication 95, MO-153



# **Ordering Information**

# **Table 9. Ordering Information**

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
843251BGI-15LF	BI15L	8 Lead TSSOP, Lead-Free	Tube	-40°C to 85°C
843251BGI-15LFT	BI15L	8 Lead TSSOP, Lead-Free	Tape & Reel	-40°C to 85°C



# **Revision History Sheet**

Rev	Table	Page	Description of Change	
		1	Deleted HiPerClockS references.	
	T4 3 7		Crystal Characteristics Table - added note.	
Α			Deleted application note, LVCMOS to XTAL Interface.	11/2/12
		10	Added Note: Thermal pad (E-pad) must be connected to ground (VEE).	
	Т9	14	Deleted quantity from tape and reel.	
			Updated header/footer throughout the datasheet.	
			Deleted IDT prefix from part number.	
Б	9		Application Information:	10/00/15
В		10	added Overdriving the XTAL Interface,	10/29/15
		11	updated Termination for 3.3V LVPECL Outputs	
	Т9	18	Ordering Information Table - deleted: leaded part rows and table note.	



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